



Sheet 2 of 2

Form PTO-1449 U.S. Patent and Trademark Office INFORMATION DISCLOSURE STATEMENT	Atty. Docket No. <b>KIN61USA</b>	Serial No. <b>10/089,626</b>
	Applicant: Fukuyo et al.	
	Filing Date: April 1, 2002	Group Art Unit: <b>1743</b>

## U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass

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## FOREIGN PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Country	Translation Yes      No
<i>JH</i>		JP 06-280009	10/1994	Japan	Abstract Only      X
<i>JS</i>		JP 10-008245	1/1998	Japan	Abstract Only      X

Other Documents (including Author, Title, Date, Pertinent Pages, Etc.)

<i>JH</i>	<i>V</i>	Umeki Takenori, "Sputtering Target", <i>Toshiba Technical Bulletin</i> , Publication No. 95-5786, Vol. 13-79, pp. 43-46, October 1995 (includes a one page English language abstract)
Examiner	<i>JH JS</i>	Date Considered <i>9-3-2003</i>

\*Examiner: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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Examiner Initial	Document No.	Date	Name	Class	Subclass
JL	6,045,634	4/2000	Annavarapu	148	671
JL	5,204,057	4/1993	Ishigami et al.	420	417
JL	4,891,066	1/1990	Shimotori et al.	75	84
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JL	B1 4793854	10/1992	Shimotori et al.	75	10.1

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Examiner Initial	Document No.	Date	Country	Translation Yes No
JL	EP 0 408 383 A1	1/1991	European	
JL	JP 07-240391	9/1995	Japan	See EP 408383 & US 5204057
JL	JP 11-229130	8/1999	Japan	See US 6045634
JL	JP 62-280335	12/1987	Japan	See US 4793854 & US 4891066

## Other Documents (including Author, Title, Date, Pertinent Pages, Etc.)

JL	Patent Abstracts of Japan, English Abstract of JP 06-280009
JL	Patent Abstracts of Japan, English Abstract of JP 10-008245
Examiner <i>John P. Shub</i>	Date Considered <i>9-3-2003</i>

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